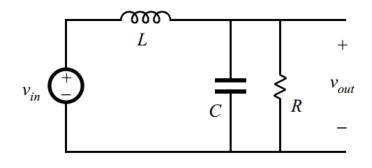
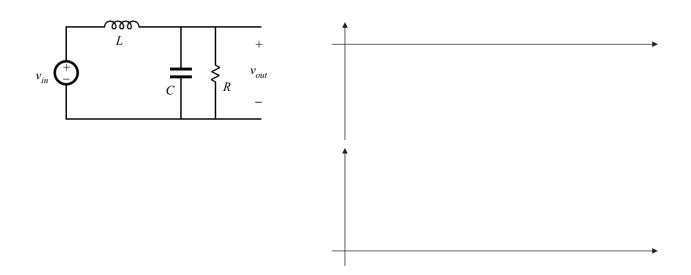
Resonant Circuits





Resonant Circuit Analysis



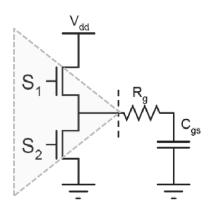


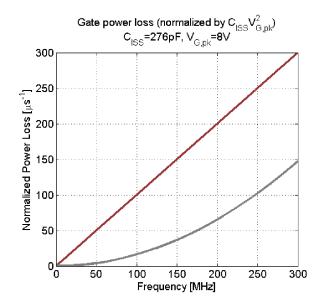
Soft Switching

- Advantages
 - Reduced switching loss
 - Possible operation at higher switching frequency
 - Lower EMI
- Disadvantages
 - Increased current and/or voltage stresses due to circulating current
 - Higher peak and rms current values
 - Complexity of analysis and modeling

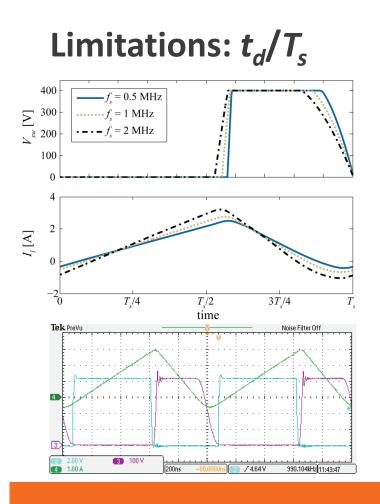


Limitations: Gate Drive



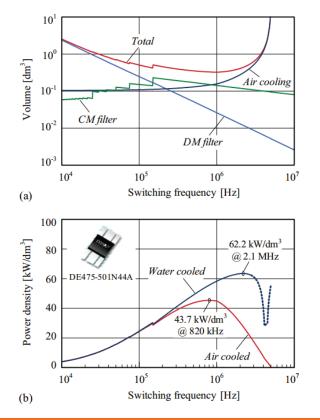






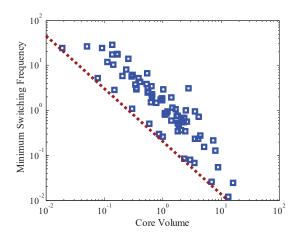


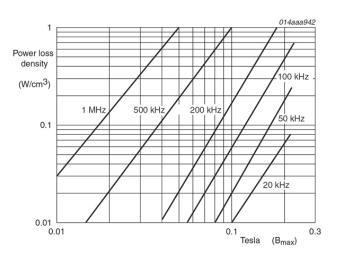
Limitations: Thermal



Kolar, J.W.; Drofenik, U.; Biela, J.; Heldwein, M.L.; Ertl, H.; Friedli, THROWNOLS, D.T. TRWN Converter Power Density Barriers," *Power Conversion Conference* 1990, 1288 Vol., no., pp.P-9,P-29, 2-5 April 2007

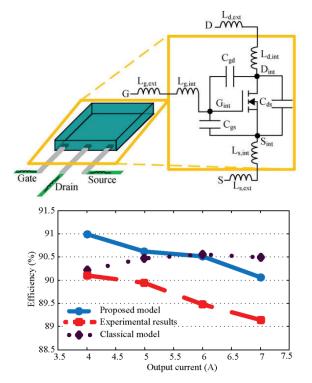
Limitations: Magnetics Design







Limitations: Circuit Modeling

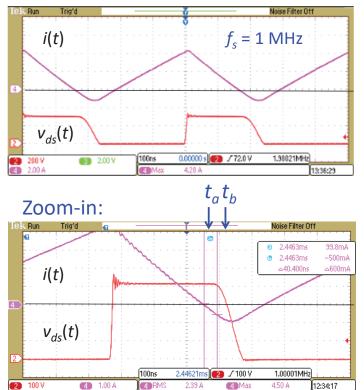


150-to-400V, 150W Boost

EXPERIMENTAL EXAMPLE



ZVS with Si diode

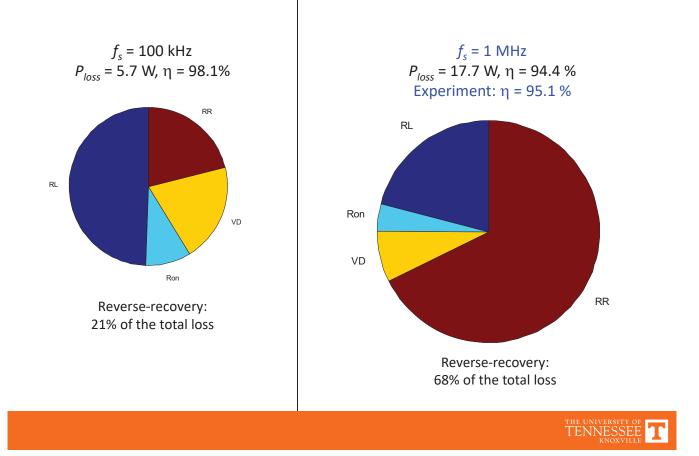


- ZVS turn-ON
 - Eliminated losses due to C_{sw} discharge during turn-ON transient
 - Eliminated losses due to MOSFET di_F/dt during turn-ON transient
- Diode reverse recovery still impacts the waveforms and losses
- Increased current ripple
 - Increased conduction losses (by >30%)
 - Increased dv_{ds}/dt upon turn-OFF, MOSFET turn-OFF speed is more important

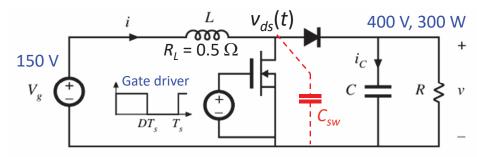
D. Costinett, D. Maksimovic, R. Zane, A. Rodríguez and A. Vázquez, "Comparison of reverse recovery behavior of silicon and wide bandgap diodes in high frequency power converters"



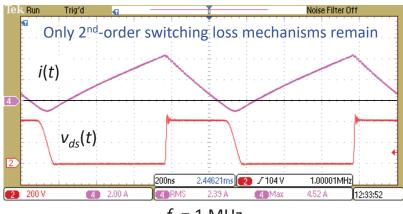
Loss Breakdown: Soft-Switched Si Boost



Soft-switched SiC diode



SiC diode, "soft-switched" operation





MOSFET

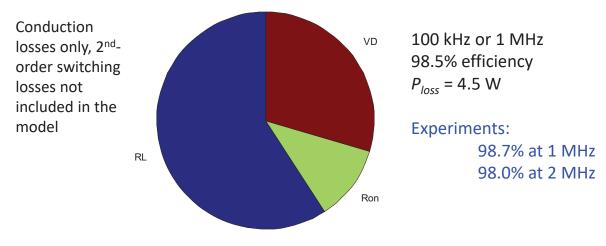
- *di_F/dt* = 200 A/µs
- *C_{ds,eq}* = 45 pF
- $R_{on} = 0.15 \Omega$

SiC diode

- $t_{rr} = 0, Q_{rr} = 0$
- $2C_{d,Qeq} C_{d,eq} = 64 \text{ pF}$
- V_D = 1.8 V



Soft-switched Boost with SiC diode



Power supply technology limits become dominated by:

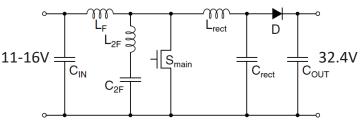
- Magnetics
- 2nd-order switching loss mechanisms, e.g. gate-drive losses, parasitic inductances (layout and packaging)
- Gate-drive circuitry and controllers to support high-frequency operation

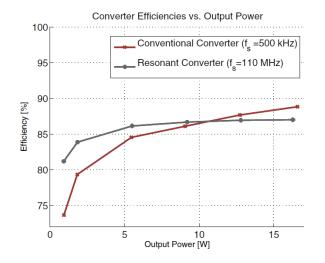


TENNES

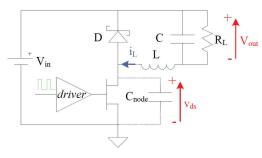
VHF power electronics [11]

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$\begin{array}{c c} L_{2F} & 12.5 \ \mathrm{nH} & \mathrm{Coilcraft} \ A\\ L_{rect} & 22 \ \mathrm{nH} & 1812S\\ C_{2F} & 39 \ \mathrm{pF} & \mathrm{ATC10}\\ C_{rect} & 10 \ \mathrm{pF} & \mathrm{ATC10}\\ C_{out} & 75 \ \mu\mathrm{F} & \mathrm{Multilayer} \ C\\ C_{in} & 22 \ \mu\mathrm{F} & \mathrm{Multilayer} \ C\\ S_{main} & \mathrm{Freescale} \ \mathrm{MF}\\ D & \mathrm{Fairchild}\\ \hline \end{array}$		
	312SMS	
$ \begin{array}{cccc} \hline C_{2F} & 39 \text{ pF} & \text{ATC10} \\ \hline C_{rect} & 10 \text{ pF} & \text{ATC10} \\ \hline C_{out} & 75 \mu\text{F} & \text{Multilayer} \\ \hline C_{in} & 22 \mu\text{F} & \text{Multilayer} \\ S_{main} & \text{Freescale MF} \\ \hline D & \text{Fairchild} \\ \hline $	404TG	
$ \begin{array}{c} C_{rect} & 10 \ \mathrm{pF} & \mathrm{ATC10} \\ C_{out} & 75 \ \mu\mathrm{F} & \mathrm{Multilayer} (\\ C_{in} & 22 \ \mu\mathrm{F} & \mathrm{Multilayer} (\\ S_{main} & \mathrm{Freescale} \ \mathrm{M} \\ D & \mathrm{Fairchild} \\ \hline \end{array} $	MS	
$ \begin{array}{ccc} C_{out} & 75 \ \mu \text{F} & \text{Multilayer O} \\ C_{in} & 22 \ \mu \text{F} & \text{Multilayer O} \\ S_{main} & & \text{Freescale MI} \\ D & & & \text{Fairchild} \\ \hline \\ \hline \hline & & & \text{Conventional Design} \end{array} $	0A	
$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	0A	
S _{main} Freescale MI D Fairchild Conventional Design	Ceramics	
D Fairchild Conventional Design	Ceramics	
Conventional Design	RF6S9060	
	S310	
	Conventional Design	
Component Value Typ	e	
L _{boost} 10 µH Coilcraft D033	16T-103ML	
C_{out} 75 μ F Multilayer (Ceramics	
C_{in} 22 μ F Multilayer G	Ceramics	
S _{main} LT1371	HV	
D Fairchild		





WBG Devices

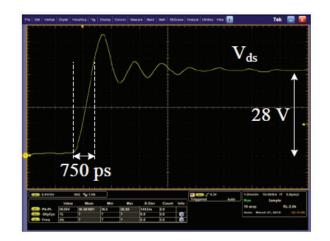


TriQuint TGF2023-02 12W, DC-to-18 GHz RF/microwave HEMT

FOM for switching applications $C_{ds}R_{on} \approx 1 \ \Omega \mathrm{pF}$

 $Q_g R_{on} \approx 10 \ \Omega pC$

Standard hard-switched PWM operation at 50 MHz dv_{ds}/dt dominated by probe (4 pF) capacitance



Emerging GaN HEMT devices may enable completely new RF-based design approaches in power electronics

M. Rodríguez, G. Stahl, D. Costinett and D. Maksimović, "Simulation and characterization of GaN HEMT in highfrequency switched-mode power converters," TENNESSEE KNOXVILLE

TENNES

Topics Covered

Course Topics

- High Frequency Power Conversion
 - Switching losses and device selection
 - Resonance in power electronics
 - Soft switching (ZVS and ZCS)
 - Magnetics design
- Non-resonant soft switching converters
 - Constant frequency control
 - State-plane analysis
 - Resonant switches
 - Modeling and Simulation
 - Discrete time models
- Resonant Converters
 - Resonant converter topologies
 - Sinusoidal analysis
 - AC-modeling and frequency modulation
 - State-plane analysis
- Applications and practical issues of high frequency converters